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Defect Engineering in Plasmonic Metal Oxide Nanocrystals

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8 **(3)** Supporting Information

ABSTRACT: Defects may tend to make crystals interesting but they do not always improve 9 performance. In doped metal oxide nanocrystals with localized surface plasmon resonance 10 (LSPR), aliovalent dopants and oxygen vacancies act as centers for ionized impurity scattering 11 12 of electrons. Such electronic damping leads to lossy, broadband LSPR with low quality factors, 13 limiting applications that require near-field concentration of light. However, the appropriate 14 dopant can mitigate ionized impurity scattering. Herein, we report the synthesis and characterization of a novel doped metal oxide nanocrystal material, cerium-doped indium 15 oxide (Ce/In_2O_3) . Ce/In₂O₃ nanocrystals display tunable mid-infrared LSPR with 16 exceptionally narrow line widths and the highest quality factors observed for nanocrystals 17 in this spectral region. Drude model fits to the spectra indicate that a drastic reduction in 18 ionized impurity scattering is responsible for the enhanced quality factors, and high electronic 19 mobilities reaching 33 $\text{cm}^2 \text{V}^{-1} \text{ s}^{-1}$ are measured optically, well above the optical mobility for 20



tin-doped indium oxide (ITO) nanocrystals. We investigate the microscopic mechanisms underlying this enhanced mobility with density functional theory calculations, which suggest that scattering is reduced because cerium orbitals do not hybridize with the In orbitals that dominate the bottom of the conduction band. Ce doping may also reduce the equilibrium oxygen vacancy concentration, further enhancing mobility. From the absorption spectra of single Ce/In_2O_3 nanocrystals, we determine the dielectric function and by simulation predict strong near-field enhancement of mid-IR light, especially around the vertices of our synthesized nanocubes.

27 KEYWORDS: Nanocrystal, doping, plasmonics, near-field enhancement, density functional theory, cerium-doped indium oxide

oped metal oxide nanocrystals display intriguing 28 composition-dependent properties. Chief among these 29 30 is near- to mid-infrared (NIR/MIR) localized surface plasmon 31 resonance (LSPR), which is induced by n-type doping to 32 generate free electrons that can participate in light-driven free 33 carrier oscillation at tunable resonant frequencies. Colloidal 34 synthesis has enabled the discovery of several doped metal 35 oxide nanocrystals with LSPR over the past decade. Key 36 examples include aluminum-doped zinc oxide (AZO),¹ indium-37 doped cadmium oxide (ICO),² and tin-doped indium oxide $_{38}$ (ITO or Sn/In₂O₃).³ These materials have been studied as thin 39 films for their transparent conductive properties, and the 40 dielectric functions known from such studies are the basis for 41 understanding the LSPR properties of the corresponding 42 nanocrystals.

LSPR excitations are confined to the physical dimensions of 44 nanocrystals and effectively concentrate light into volumes well 45 below the diffraction limit. As a result, very intense local field 46 "hotspots" are formed around the nanocrystals that can interact 47 with nearby molecules or materials. This near-field enhance-48 ment makes doped metal oxide nanocrystals good candidates 49 for NIR and MIR near-field optics and enhanced spectroscopies 50 like surface-enhanced infrared absorption spectroscopy (SEIRA). Efficient hot spot generation requires a high quality $_{51}$ factor (Q, the ratio of the peak energy to the width of the LSPR $_{52}$ peak), which implies longer plasmon lifetimes, weaker $_{53}$ electronic damping, and stronger near-field intensities. Thus, $_{54}$ it is important to consider not only how dopants in metal $_{55}$ oxides tune the LSPR frequency by changing the free carrier $_{56}$ concentration but also how their presence contributes to $_{57}$ damping by scattering the oscillating free electrons. To create $_{58}$ high-Q MIR plasmonic materials, strategies are needed to $_{59}$ minimize scattering even as substantial concentrations of $_{60}$ dopants are introduced.

To account for both free carrier concentration and electronic ⁶² damping, the dielectric function of a doped oxide nanocrystal ⁶³ can be represented by the Drude model extended to include a ⁶⁴ frequency-dependent contribution to the damping of oscillating ⁶⁵ free carriers ⁶⁶

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$$\varepsilon(\omega) = \varepsilon_{\infty} - \frac{\omega_{\rm p}^2}{\omega^2 + i\omega\Gamma(\omega)} \tag{1}$$

68 where $arepsilon_\infty$ is the high-frequency permittivity, $\Gamma(\omega)$ is the 69 electronic damping function, and $\omega_{\rm P}$ is the plasma frequency, 70 proportional to the square root of the carrier concentration. 71 The magnitude of Γ is critical because it determines the LSPR 72 line width (i.e., Q) and its functional form reflects the frequency 73 dependence of electronic scattering by charged point defects; 74 such ionized impurity scattering acutely hampers electron 75 transport and reduces mobility. This is particularly important 76 for doped metal oxides, as aliovalent dopants are necessary for 77 free carrier generation, and oxygen vacancies, as doubly ionized 78 defects, scatter electrons four times more strongly than singly 79 ionized defects.^{4–6} LSPR behavior therefore depends critically 80 on how dopants influence defect chemistry, carrier scattering, 81 and mobility. We recently demonstrated the importance of 82 defects in determining LSPR properties by showing that Sn/ 83 In₂O₃ nanocrystals with surface-segregated tin display signifi-84 cantly narrower and more symmetric LSPR peaks compared to 85 nanocrystals with homogeneously distributed tin owing to a decrease in ionized impurity scattering. 86

Deliberate defect engineering, that is, rational dopant 87 selection and minimization of vacancy concentration, has 88 89 been explored in transparent conducting oxide thin films as a 90 viable strategy to combat ionized impurity scattering. For 91 example, Mo-doped In₂O₃ thin films have higher electron 92 mobility than Sn/In₂O₃. Unlike Sn orbitals, Mo orbitals do not 93 hybridize with the conduction band minimum (CBM), leading 94 to stronger electrostatic screening of dopant potentials and 95 reduced ionized impurity scattering.⁸ Likewise, Dy-doped CdO 96 thin films exhibit exceptional electronic mobility and large 97 predicted plasmon quality factors because Dy dopants modify 98 the defect equilibria to minimize oxygen vacancy concen-99 tration.⁹ Doping with Dy³⁺ also minimizes local strain and the 100 associated electron-phonon scattering because it is a close 101 match to Cd²⁺ in ionic radius.

Applying these strategies to indium oxide reveals cerium as a 102 103 promising dopant. Cerium is significantly more electropositive 104 than In and Sn, which implies that Ce states may lie within the 105 conduction band of In₂O₃, limiting hybridization at the CBM 106 and leading to remote screening of dopants as in Mo-doped 107 In_2O_3 . As an electropositive dopant, Ce may also be a more 108 energetically stable electron donor than oxygen vacancies, 109 which could modify the defect equilbria to inhibit oxygen 110 vacancy formation. Finally, the six-coordinate crystal ionic 111 radius of Ce^{4+} (101 pm) is a closer match to In^{3+} (94 pm) than 112 is Sn⁴⁺ (83 pm),¹⁰ which implies that cerium doping may 113 reduce lattice strain compared to Sn/In₂O₃ in a manner 114 analogous to Dy in CdO. We therefore hypothesized that 115 cerium-doped indium oxide (Ce/In₂O₃) nanocrystals would 116 display higher electronic mobility and higher Q LSPR peaks 117 compared to Sn/In₂O₃. The few literature accounts of Cedoped In₂O₃ thin films report high mobility, which supports 118 119 this hypothesis, though these studies used tin or hydrogen as codopants and did not study the microscopic mechanisms 120 121 responsible for enhanced mobility.^{11,12}

For the first time, we synthesized colloidal Ce/In_2O_3 nanocrystals by adapting a typical procedure used to synthesize Sn/In_2O_3 nanocrystals.^{3,7} In brief, indium acetylacetonate, a cerium precursor, and oleylamine were mixed and heated to $126\ 250\ ^{\circ}C$ for 2 h to form colloidal nanocrystals under an inert atmosphere using standard Schlenk line techniques. Doping levels were measured with inductively coupled plasma optical 128 emission spectroscopy (ICP-OES). Transmission electron 129 microscopy (TEM, Figure 1a–d and Figure S1) reveals that 130 fl



Figure 1. Physical characterization of Ce/In₂O₃ nanocrystals. (a) TEM micrograph of cubic Ce/In₂O₃ nanocrystals doped with 5.2% Ce (from Ce-acac). (b) TEM micrograph of pseudospherical Ce/In₂O₃ nanocrystals doped with 6.4% Ce (from Ce-TMHD). (c) HRTEM image of cubic nanocrystal with FFT in inset. (d) HRTEM of spherical nanocrystal with FFT in inset. (e) Representative powder XRD patterns for Ce/In₂O₃ nanocrystals, confirming the indium oxide cubic bixbyite structure (reference PDF pattern shown at bottom). The sharp peaks marked with a (*) are due to the substrate.

the nanocrystals are relatively uniform and highly crystalline. X- 131 ray diffraction (XRD, Figure 1e) confirms the crystallinity of 132 Ce/In₂O₃ nanocrystals, which have the cubic bixbyite crystal 133 structure typical of bulk In₂O₃, without detectable impurity 134 phases. Rietveld refinement performed on the XRD patterns 135 (Figure S2) showed that the lattice parameter increased slightly 136 with Ce doping along a trajectory well-fit by Vegard's law. 137 Owing to the larger ionic radius of cerium, this lattice expansion 138 signifies effective substitutional dopant incorporation. We 139 prepared a doping series from 0% Ce to 11.1% Ce using 140 cerium acetylacetonate (Ce-acac) as a dopant source, and we 141 also evaluated other precursors, namely cerium tetramethyl- 142 heptanedionate (Ce-TMHD), cerium ammonium nitrate, and 143 cerium acetate. All dopant precursors produced colloidally 144

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Figure 2. Optical properties of Ce/In_2O_3 nanocrystals. (a) FTIR liquid cell spectra of Ce/In_2O_3 and Sn/In_2O_3 nanocrystals dispersed in tetrachloroethylene showing narrow and tunable MIR LSPR of Ce/In_2O_3 . (b) Tauc plot showing systematic increase of Ce/In_2O_3 optical bandgap with Ce content consistent with a Burstein–Moss shift. (c) LSPR of 5.2% Ce-doped In_2O_3 dispersed in nonpolar solvents with different refractive indices. Inset: LSPR peak wavelength vs refractive index.

145 stable and highly crystalline nanocrystals with narrow MIR 146 LSPR absorption, though LSPR peak shape and nanocrystal 147 shape depended on the amount and type of cerium precursor 148 used. For example, nanocrystals synthesized with Ce-acac 149 tended to adopt cubic shapes with (100)-terminated facets, 150 while those synthesized with Ce-TMHD were pseudospherical. 151 As we show below, consistent with previously published 152 simulations of ICO nanocrystals,¹³ the synthesis of nanocrystals 153 in shapes with defined corners and edges has positive 154 implications for near-field enhancement.

Liquid-cell Fourier transform infrared (FTIR) spectra of Ce/ 155 156 In₂O₃ nanocrystals dispersed in tetrachloroethylene display 157 remarkably narrow LSPR peaks that are air-stable (Figure 2a). The peak energy increases with Ce content, indicating donor 158 159 dopant behavior. The UV optical bandgap shifts systematically 160 to higher energy with increased doping (Figure 2b) as free 161 conduction band electrons populate band edge states in ¹⁶² accordance with observations of the Burstein–Moss effect in ¹⁶³ other doped oxide nanocrystals.^{1,2} Dispersing the nanocrystals 164 in nonpolar solvents with increasing refractive index results in a 165 systematic redshift in LSPR peak position (Figure 2c). When 166 the wavelength of the extinction peak is plotted versus 167 refractive index (Figure 2c inset), a linear trend is observed, consistent with the expected sensitivity of LSPR to the 168 169 dielectric environment. These LSPR peaks are exceptionally 170 narrow and symmetric, especially compared to Sn/In₂O₃ 171 nanocrystals with LSPR in the same spectral region (Figure 2a). The narrowest peak occurs for nanocrystals doped with 172 5.2% Ce, which display an LSPR peak at 2522 cm⁻¹ with a 173 width of only 621 cm⁻¹ (77 meV) for a quality factor of 4.08. 174 To our knowledge, this is higher than the Q values for gold 175 176 nanostructures, nitrides, chalcogenides, and other doped metal oxide nanocrystals with LSPR in or approaching this spectral 177 178 region.^{1,2,4,7,14–22} Furthermore, these peak widths are among 179 the narrowest reported for any plasmonic nanoparticle, 180 including single gold nanoparticles (120 meV),²³ Sn/In₂O₃ 181 (113 meV),⁷ and ICO codoped with fluorine (59 meV).²

Narrow and symmetric LSPR peaks indicate low levels of 182 electronic damping and ionized impurity scattering.^{4,7} To 183 quantify these electronic properties, we performed fits to the 184 FTIR spectra with an extended Drude model using a MATLAB 185 code developed by our group.^{7,25–27} In contrast to a simple 186 Drude approximation, our model employs an empirical 187 frequency-dependent damping function ($\Gamma(\omega)$ in eq 1) to 188 account for the frequency dependence of ionized impurity 189 scattering: 190

$$\Gamma(\omega) = \Gamma_{\rm L} - \frac{\Gamma_{\rm L} - \Gamma_{\rm H}}{\pi} \left[\tan^{-1} \left(\frac{\omega - \Gamma_{\rm X}}{\Gamma_{\rm W}} \right) + \frac{\pi}{2} \right]$$
(2) [19]

where $\Gamma_{\rm L}$ is a low-frequency damping constant, $\Gamma_{\rm H}$ is a high- ¹⁹² frequency damping constant, $\Gamma_{\rm X}$ is a crossover frequency ¹⁹³ between the low-frequency and high-frequency damping ¹⁹⁴ regimes, and $\Gamma_{\rm W}$ is the width of the crossover region.²⁸ The ¹⁹⁵ magnitude of the low-frequency damping constant captures the ¹⁹⁶ influence of ionized impurity scattering, and when $\Gamma_{\rm L} \gg \Gamma_{\rm H}$ ¹⁹⁷ frequency-dependent ionized impurity scattering is a dominant ¹⁹⁸ LSPR damping mechanism. At sufficiently low frequencies, ¹⁹⁹ oscillating electrons effectively feel the same scattering ²⁰⁰ potentials as they would under a DC field, so fits to the ²⁰¹ spectra can be used to calculate optical DC electronic mobility ²⁰² by the following relationships⁷

$$\sigma_{\rm opt} = en\mu_{\rm opt} = \frac{ne^2}{m^*\Gamma(0)} \tag{3}_{204}$$

where σ_{opt} is the optically derived electronic conductivity, μ_{opt} is 205 the optically derived electron mobility, *n* is the free carrier 206 concentration, m^* is the effective mass of an electron, and $\Gamma(0)$ 207 is the value of the damping function (eq 2) at zero frequency. 208 Electronic properties derived optically by this method have 209 been found to match physically measured properties, including 210 mobility, in both dense thin films and electronically connected 211 nanocrystalline films.^{26,29–31} 212



Figure 3. Drude modeling of LSPR in Ce/In₂O₃ nanocrystals. (a) Example extended and simple Drude model fits to the FTIR spectrum of 5.2% Ce/In₂O₃ nanocrystals. (b) Optically calculated electronic mobility of Ce/In₂O₃ (blue circles), Sn/In₂O₃ (red triangles), and Ce/Sn-codoped In₂O₃ nanocrystals (purple, inverted triangles) versus doping level. (c) Low-frequency damping constant, calculated with the extended Drude model, for Ce/In₂O₃, Sn/In₂O₃, and Ce/Sn-codoped In₂O₃ nanocrystals versus doping level.

We calculated the plasma frequency, electron concentration, 213 214 damping constants, and electronic mobility for Ce/In₂O₃ nanocrystals and compared them to Sn/In₂O₃ nanocrystals 215 containing 1 to 4% Sn. A representative fit and the salient fitting 216 results are shown in Figure 3 and Table S1. The remaining 217 Drude fits are shown in Figure S3. In Ce/In_2O_3 , the crossover 218 219 frequencies are significantly blueshifted relative to the LSPR peak energy with narrow crossover widths and low $\Gamma_{\rm L}$ values. 220 221 This is indicative of damping by a frequency-independent constant throughout the bandwidth of the LSPR peak and 222 suppressed ionized impurity scattering.⁷ When we fit the 223 224 spectra using a simple Drude model with constant damping, the fits were nearly identical (Figure 3a, Table S2), supporting this 225 conclusion. Figures 2a and S3 show a limited blueshift in the 226 227 LSPR peak at doping levels higher than 5.2%, suggesting 228 diminished donor character at higher Ce concentration. This is 229 in contrast to Sn/In₂O₃, which has a stronger LSPR blueshift with Sn content. Comparing the electron concentrations 230 determined by Drude analysis to Ce concentration reveals 231 232 that a significant number of dopants are not activated as donors (Figure S4), as is typical for degenerately doped metal oxides. 233 X-ray absorption spectroscopy (XAS) revealed that a significant 234 fraction of Ce dopants were not ionized, which is most likely a 235 consequence of cerium's facile transition between the 3+ and 236 oxidation states. We note that more complex defect 4+ 237 chemistries are also possible and may be consuming free 238 electrons, because the electron concentrations were generally 239 lower than expected based on the Ce⁴⁺ fraction determined by 240 XAS. For example, defect clustering between dopants and 241 oxygen interstitials is a well-known phenomenon in bulk Sn/ 242 $In_2O_3^{32}$ and has been observed in plasmonic Sn/In₂O₃ 243 nanocrystals.³³ Similar defect equilibria may also contribute to 244 245 limited activation at higher doping levels in Ce/In₂O₃.

The values for μ_{opt} and Γ_L (Figure 3b,c) underscore the 247 exceptional electronic properties of Ce/In₂O₃. Both the low-248 and high-frequency damping constants are significantly lower 249 than for Sn/In₂O₃ nanocrystals, and the 2.0–5.2% Ce-doped 250 samples outperform our previously reported best performance 251 from 6.4% Sn-doped In₂O₃ (Γ_L = 913 cm⁻¹).⁷ We also 252 confirmed the deleterious effects of tin doping by preparing Ce/Sn-codoped samples; incorporation of only 1%–2% Sn 253 significantly decreased mobility and increased both the low- 254 and high-frequency damping constants (Figure 3b,c), but these 255 nanocrystals nevertheless displayed enhanced properties 256 relative to nanocrystals doped with tin only. In particular, the 257 low $\Gamma_{\rm L}$ values quantitatively describe how ionized impurity 258 scattering is suppressed in Ce/In₂O₃ compared to Sn/In₂O₃. 259 Furthermore, the extracted frequency-dependent damping 260 functions translate to high electronic mobility as calculated by 261 eq 3; we calculated mobilities up to 33 cm²V⁻¹ s⁻¹, twice what 262 we observed for Sn/In₂O₃ nanocrystals.

The observed mobility trends suggest that cerium incorpo- 264 ration suppresses ionized impurity scattering by influencing 265 crystal structure, electronic structure, or both. Furthermore, the 266 electronic mobility in Ce/In₂O₃ actually increases substantially 267 with doping level up to 5.2% Ce. These results are contrary to 268 conventional models of ionized impurity scattering, which 269 predict a decrease in mobility with doping.^{6,34} To evaluate the 270 microscopic origins of the electronic property enhancements, 271 we performed density functional theory (DFT) calculations 272 using the Vienna ab initio simulation package (VASP) to 273 simulate local strains, defect formation energies, and electronic 274 structure in Ce/In₂O₃.^{35–38} In all calculations, doping was 275 simulated by replacing a Wyckoff *8b* In site with Ce or Sn. 276

Using a GGA+U exchange correlation functional, we first 277 calculated radial strains surrounding an oxygen vacancy, a 278 substitutional Ce dopant, and a substitutional Sn dopant in a 279 80-atom In₂O₃ bixbyite unit cell, corresponding to a cation 280 doping level of 3.1% (Figure S5).³⁹ The magnitude of the 281 nearest neighbor strain around cerium (\sim 4%) is slightly lower 282 than tin (\sim 5%). This slight decrease in lattice distortion is 283 probably not the primary driver of high mobility, though it may 284 be responsible for some decrease in frequency-independent 285 electron-phonon scattering. By contrast, the strain around an 286 oxygen vacancy is up to three times greater and decays over a 287 longer distance, which would cause strong electron-phonon 288 scattering through lattice distortion. Furthermore, the ionized 289 impurity scattering potentials from ionized oxygen vacancies 290 are strongly felt by free electrons due to the significant 291 contribution of oxygen orbitals to the conduction band.^{8,40} 292

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Figure 4. DFT calculations on Ce/In₂O₃ and Sn/In₂O₃. (a) Defect formation energies versus Fermi level for oxygen vacancies ($V_0^{\circ\circ}$), substitutional tin dopants (Snⁱⁿ, and substitutional cerium dopants (Ceⁱⁿ) under oxygen-poor conditions. The valence band maximum is set to 0 eV and the gray-shaded region denotes the conduction band edge. The slope of the formation energy versus Fermi level reflects the stable charge state of the defect at that Fermi level. (b) Defect formation energies versus Fermi level under oxygen-rich conditions. (c) Total and partial density of states for a 40 atom primitive In₂O₃ unit cell containing one substitutional Ce dopant. The valence band maximum is set to 0 eV. (d) Detailed view of the total and partial DOS at the conduction band edge for Ce/In₂O₃. (e) Total and partial DOS at the conduction band edge view of the total and partial DOS at the conduction band edge for Sn/In₂O₃.

293 Considering strong electron scattering by oxygen vacancies, 294 the incorporation of Ce might suppress ionized impurity 295 scattering by reducing the equilibrium concentration of oxygen 296 vacancies. We therefore used DFT to calculate the defect 297 formation energies for an oxygen vacancy, a substitutional 298 cerium dopant, and a substitutional tin dopant in a bixbyite unit 299 cell according to the following equation

$$E_{\text{defect}}[X^q] = E_{\text{DFT}}[X^q] - E_{\text{DFT}}[\text{bulk}] - \sum_i n_i \mu_i + q E_{\text{F}} + E_{\text{corr}}$$
(4)

301 where $E_{\text{deffect}}[X^q]$ is the formation energy of a defect X with 302 charge q, $E_{\text{DET}}[X^q]$ is the total energy of the defective cell 303 calculated by DFT, E_{DET} [bulk] is the total energy of the perfect 304 cell, n_i and μ_i are the number and chemical potential, 305 respectively, of the atoms added or subtracted from the cell 306 to form the defect, $E_{\rm F}$ is the Fermi level relative to the valence 307 band maximum, and $E_{\rm corr}$ is a correction factor that accounts for 308 potential alignment and image charges of the defect that arise 309 during DFT calculations.⁴¹ This treatment captures the 310 dependence of defect formation energies on the Fermi level 311 as well as the chemical potential of oxygen, allowing us to 312 display these energies as a function of $E_{\rm F}$ under oxygen-poor 313 and -rich conditions (see SI for a more detailed explanation). We note that the oxygen-poor case, corresponding to the 314 minimum chemical potential of oxygen for which In₂O₃ is 315 316 stable with respect to decomposition into indium metal and O_{2} 317 likely matches our anaerobic synthetic environment more 318 closely, especially considering the precipitation of bulk metal 319 observed in some similarly performed nanocrystal synthe-320 ses.^{21,42,43}

We calculated defect formation energies for oxygen vacancies and substitutional tin in both the oxygen-poor (Figure 4a) and oxygen-rich (Figure 4b) limits, and they agree well with the previous computational studies.^{44,45} Our calculations also

indicate that under oxygen-poor conditions, the formation of 325 substitutional Ce defects is significantly more energetically 326 favorable than substitutional tin or oxygen vacancies, which 327 have comparable formation energies. The energy difference 328 between substitutional Ce and Sn arises primarily from the 329 $E_{\text{DET}}[X^q]$ term, the energy of a unit cell with one Ce defect is 330 about 3.5 eV lower than a unit cell with one Sn defect, while the 331 chemical potential and correction terms in eq 4 differ by 0.5 eV 332 or less between Ce and Sn doping. Incorporation of Ce or Sn 333 donors increases the Fermi level, which consequently increases 334 the formation energy of oxygen vacancies by over 3 eV as the 335 Fermi level reaches the CBM. For a given electron 336 concentration, it is much more energetically favorable to 337 compensate free electrons with Ce donors as opposed to 338 oxygen vacancies. In Sn/In₂O₃, the energy difference between 339 substitutional Sn and oxygen vacancies is significantly smaller, 340 so free electrons would more likely be compensated by a mix of 341 both defects. Figure 4a also shows that neutral defects become 342 favorable at higher Fermi levels, indicating the presence of both 343 ionized and neutral dopants, which agrees with our observation 344 of partial dopant activation. Overall, when comparing Ce/In₂O₃ 345 and Sn/In₂O₃ at the same electron concentration, our results 346 suggest that oxygen vacancies may be more prominent in the 347 latter. This interpretation is consistent with our observations 348 that the electronic mobility in Ce/In₂O₃ nanocrystals increases 349 significantly with Ce concentration, while the electronic 350 mobility in Sn/In₂O₃ nanocrystals does not increase with Sn 351 doping. 352

The formation energies of Ce and Sn substitutional defects 353 change progressively with oxygen chemical potential, eventually 354 crossing over so that Sn is more favorable than Ce at oxygen- 355 rich conditions (where the chemical potential of oxygen is set 356 equal to the energy of O in an O₂ molecule, Figure 4b). This 357 manifests at high oxygen activity because CeO₂ has a 358 significantly lower chemical potential than SnO₂ (by about 5 359

360 eV, see Tables S3 and S4); the chemical potentials of these two 361 oxides set the oxygen-rich boundary conditions for eq 4 and 362 under these conditions the chemical potential difference 363 overwhelms the difference in the $E_{\text{DET}}[X^q]$ term. Between 364 these two extremes of oxygen chemical potential, substitutional 365 Ce remains more favorable (Figure S6). At the oxygen-rich 366 extreme, the formation energy for all three defects is positive 367 over nearly the whole range of Fermi levels, indicating that n-368 type doping would be difficult under these conditions. These 369 conditions are unlikely to be encountered experimentally, and 370 high oxygen partial pressures are associated with other deleterious effects in Sn/In₂O₃, such as defect clusters of tin 371 372 and oxygen interstitials, which consume free electrons upon formation.³² 373

Finally, we considered electronic structure as an explanation 374 375 for low ionized impurity scattering in Ce/In₂O₂. Because Ce is significantly more electropositive than In, hybridization 376 between dopant orbitals and the states near the CBM should 377 be limited. To test this hypothesis, we used DFT to calculate 378 the electronic density of states (DOS) for a 40 atom primitive 379 bixbyite unit cell with one substitutional Ce or Sn dopant, 380 which corresponds to a doping level of 6.3% (Figure 4c,d). 381 Here, we used the HSE06 hybrid functional to obtain a more 382 accurate description of electronic structure, faithfully reproduc-383 ing indium oxide's fundamental bandgap of 2.7 eV.^{40,46-48} We 384 also calculated the DOS of Sn/In2O3 (Figure 4e,f) and 385 stoichiometric In₂O₃ for comparison (Figure S7). The partial 386 387 density of states (PDOS) reveal that the bottom of the 388 conduction band is primarily of In 5s and O 2s character, which 389 implies a wide and dispersive conduction band that facilitates 390 high electron mobility. The only dopant states that overlap in energy with the bottom of the conduction band are Ce 4f 391 392 states, which are highly localized states that should resist mixing with s and p orbitals. The Ce 6s and 5p states, which could 393 394 hybridize more strongly, contribute no PDOS to the CBM and only become significant about 1 eV above the band edge. By 395 contrast, Sn 5s states are present at the CBM in our Sn/In₂O₃ 396 calculations, and previous studies have shown strong hybrid-397 ization between these and In 5s orbitals.^{8,49} Optical bandgap 398 measurements (Figure 2b) suggest that the Fermi level for the 399 5.2% Ce-doped sample (with the highest mobility) is about 0.2 400 eV above the CBM or about 2.9 eV above the valence band 401 edge. Electrons near the Fermi level that contribute to 402 conductivity and LSPR are thus unlikely to interact 403 substantially with the Ce dopants, while they interact strongly 404 with Sn dopants. 405

In effect, the electronic structure of Ce/In_2O_3 is such that the 406 407 dopant ions are effectively electrostatically screened and are not 408 expected to strongly scatter free electrons. Moving electrons in Ce/In₂O₃ effectively experience the same electronic potentials 409 $_{410}$ as they would in intrinsic In₂O₃ due to this remote screening, 411 limiting ionized impurity scattering in a manner analogous to 412 modulation doping, where ionized dopants are spatially separated from conducting electrons.⁵⁰ Here, the electronic 413 separation in energy and/or orbital shape of dopant levels from 414 the conduction states suppresses ionized impurity scattering 415 416 and is likely the primary driver of enhanced mobility. Combined with our defect calculations, which suggest reduced 417 oxygen vacancy concentrations with Ce doping, these electronic 418 419 structure effects explain why we observe such narrow LSPR 420 peaks and high electronic mobilities in Ce/In₂O₃ nanocrystals. On the basis of their exceptional LSPR properties, we set out 421 422 to evaluate the potential of Ce/In₂O₃ nanocrystals for near-field

enhancement applications. We measured absorption spectra of 423 single nanocrystals using synchrotron infrared nanospectro- 424 scopy (SINS, Figure 5a), which utilizes near-field concentration 425 f5



Figure 5. LSPR properties of Ce:In_2O_3 single nanocrystals. (a) Experimentally collected SINS spectrum (red line) of a single cubic nanocrystal with 5.2% Ce, simulated SINS spectrum (green line) used to determine the dielectric function and simulate the absorption spectrum (blue line) of a single isolated nanocrystal. Inset: TEM of the nanocrystal used as a model. (b) Simulated near-field intensity map of the model nanocrystal illuminated at the LSPR peak frequency. (c) Depiction of the geometry used to model and discretize the coupled substrate–nanocrystal–tip system in the SINS experiment (drawn to scale except for the thickness of the Si substrate).

of light by a metallic AFM tip positioned just above an isolated 426 nanoscale object (Figure 5c) to collect an FTIR spectrum of 427 that object.⁵¹ Our group has recently pioneered the use of this 428 technique to interrogate single Sn/In2O3 and AZO nanocrystals 429 in order to measure LSPR properties without the influence of 430 ensemble peak broadening due to size, shape, or dopant 431 heterogeneity.⁵² We collected SINS spectra (which can 432 effectively correspond to absorption spectra)⁵³ of several 433 individual cubic-shaped Ce/In2O3 nanocrystals with average 434 5.2% Ce (Figures 5a and S8) and observed line widths as 435 narrow as 479 cm⁻¹ (59 meV), corresponding to a quality 436 factor of 5.5 for a single nanocrystal, compared to 4.08 for the 437 ensemble, meaning that some peak broadening is the result of 438 inhomogeneous broadening. This result highlights the 439 plasmonic performance of Ce/In2O3 nanocrystals and the 440 usefulness of SINS; the plasmonic damping in this material is 441 actually nearly 25% less than ensemble measurements suggest. 442

To simulate near-field enhancement around a nanocrystal, it 443 is necessary to know its frequency-dependent dielectric 444 function (eq 1). Here, we use the SINS spectrum of a single, 445 isolated nanocrystal to extract a materials-specific dielectric 446 function free of effective medium complications and artifacts 447 that would arise from ensemble peak broadening. Experimental 448 SINS spectra contain the scattering and absorption properties 449 of a coupled PtSilCe/In₂O₃lAu (tip–nanocrystal–substrate) 450 system; to accurately generate a dielectric function for the Ce/ 451 In₂O₃ nanocrystal free of tip or substrate influence, we 452 453 computationally solved Maxwell's equations for this system 454 using the finite element method (COMSOL multiphysics 455 program) to discretize each component. Using our ensemble 456 Drude model fit as an initial guess for the nanocrystal dielectric 457 function, along with known dielectric functions for PtSi and Au, 458 we simulated the SINS spectrum and iteratively adjusted the 459 plasma frequency and damping functions in the dielectric 460 function until the simulated spectrum matched the exper-461 imentally measured spectrum (Figures 5a, S9). The dielectric 463 simulate the absorption, scattering, and near-field properties of 464 an isolated nanocrystal without tip or substrate influence.

We simulated the enhancement of incident light electric field 465 466 intensity around a cubic Ce/In₂O₃ nanocrystal by using the 467 dielectric function to solve Maxwell's equations throughout the 468 discretized nanocrystal (Figure 5b). Incident light, polarized $_{469}$ along one of the cube axes and with a frequency of 2581 cm⁻¹, 470 excites a dipolar LSPR mode with a maximum near-field 471 intensity enhancement factor of 215 relative to the incident 472 intensity. The electric-field and near-field enhancement maps of 473 other modes are shown in Figure S10. The benefits of 474 nanocrystal shape control are clear, as the near-field enhance-475 ment is strongest near the cube vertices, and simulated near-476 field enhancement factors around a spherical Ce/In₂O₃ 477 nanocrystal reached only 81 (Figure S11). These simulations underscore the advantages of low loss Ce/In₂O₃ nanocrystals 478 479 for field-enhancement applications like SEIRA.

480 We have shown here that by purposefully choosing a dopant 481 that minimizes ionized impurity scattering, doped metal oxide 482 nanocrystals can exhibit high electronic mobilities, very narrow 483 LSPR peaks, and strong near-field enhancement. The predicted 484 near-field performance of Ce/In2O3 nanocrystals points to their 485 potential for applications that rely on intense light concen-486 tration well below the diffraction limit. Ce/In₂O₃ nanocrystals 487 would be good candidates for SEIRA substrates, where they 488 could be tuned to resonantly couple to and enhance molecular 489 vibration signals throughout the MIR for spectroscopy or 490 sensing applications. From an application perspective, the 491 colloidal nature of Ce/In₂O₃ provides a distinct advantage: 492 many of the other recently described systems with MIR ⁴⁹³ plasmons, including nanostructured Sn/In_2O_3 thin films,⁵⁴ ⁴⁹⁴ patterned graphene,⁵⁵ doped silicon nanowires,⁵⁶ or gold 495 antenna arrays,⁵⁷ require complex lithography or other 496 nanostructuring techniques that limit options for their 497 integration in different environments and effectively preclude 498 large scale applications. In contrast, colloidal nanocrystals are 499 readily dispersed in fluid environments or on substrates and can 500 be made to self-assemble into superlattices⁵⁸⁻⁶⁰ (with 501 plasmonic hotspots between nanocrystals⁶¹), and colloidal ⁵⁰² synthesis has been demonstrated as a scalable technique.⁶²

We hope that this report spurs additional research and 503 504 development of Ce/In₂O₃, specifically. On the basis of our 505 results, Ce/In₂O₃ offers a rich platform for studying the 506 interplay between synthesis, defect chemistry, electronic properties, and performance. For example, Ce/In2O3 thin 507 films would be particularly useful for transparent conductor 508 509 applications that require low carrier concentration and high 510 mobility, such as thin film photovoltaics.⁶ Finally, the strategies 511 incorporated here, rational dopant selection and defect 512 engineering, could be applied to manipulate the electronic 513 and plasmonic properties of any number of doped metal oxides. 514 This suggestion comes at a time that growing efforts are 515 underway to discover new transparent conductors incorporat522

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ing unusual dopants,^{8,9} multiple elements,^{63,64} or correlated s₁₆ electron metals.⁶⁵ To advance the understanding and control of s₁₇ LSPR in doped oxide nanocrystals, we plan to extend this s₁₈ strategy to study the influence of alternative dopants on the s₁₉ LSPR properties in other metal oxide hosts like TiO₂, ZnO, and s₂₀ SnO₂.

ASSOCIATED CONTENT

Supporting Information

The Supporting Information is available free of charge on the 524 ACS Publications website at DOI: 10.1021/acs.nano- 525 lett.6b01171. 526

Details of nanocrystal synthesis, sample characterization 527 and analysis (TEM, XRD, FTIR, UV–vis), details of 528 Drude modeling and analysis with additional discussion, 529 details of XAS characterization and additional discussion, 530 details of DFT calculations and analysis along with 531 additional discussion, details of SINS single-nanocrystal 532 measurements, and details and additional discussion of 533 near-field simulations. (PDF) 534

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Notes

The authors declare no competing financial interest. 539

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